## MLX90392

#### **3D Magnetometer**

Datasheet



## **Features and Benefits**

- 3-axis magnetometer device suitable for compass and position sensors applications
   Triaxis→ Hall Technology
- Suitable for space constrained applications (only 2 x 2.5 x 0.4 mm³)
- Compatible with I<sup>2</sup>C (0.1, 0.4, 1.0 MHz)
- Low power application Power-down current of 1.5μA
- Supply voltage of 1.8V
- Ambient temperature range from -40°C to 85°C
- Digital Output
  - 16-bit Magnetic (XYZ)
  - o 16-bit Temperature
- At runtime selectable modes
  - Single Measurement
  - Continuous Mode up to 1.4kHz (XYZ)
  - o Power-Down Mode
- RoHS Compliant & Green Package





UTDFN-8

## **Application Examples**

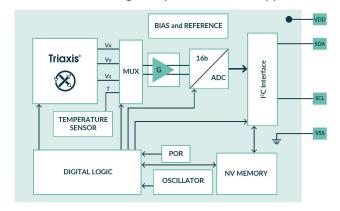
- Power tools screwdriver trigger
- Home security door/window opening detection
- Knobs for white goods rotary, linear, push
- PC peripheral mouse roller
- Gaming joystick, camera gimbal
- Anti-tamper for energy metering
- Human-machine interface

## **Description**

The device measures magnetic fields along the 3 axis and is specifically designed for micro-power applications. Those measurements and the IC temperature are transferred upon request over I<sup>2</sup>C communication channel. The device transmits compensated 16-bit raw measurement data.

The MLX90392 is available in 2 magnetic versions:

- ±5mT range for low noise applications
- ±50mT range for position sensor applications



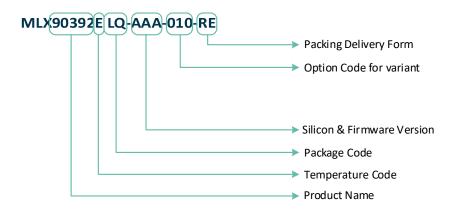


# 1. Ordering Information

Ordering Code	Temperature	Package	Туре	Output	7-bit I <sup>2</sup> C address	Packing
MLX90392ELQ-AAA-010-RE	-40°C to 85°C	UTDFN-8 2x2.5	±5mT	$I^2C$	0x0C	Reel
MLX90392ELQ-AAA-011-RE	-40°C to 85°C	UTDFN-8 2x2.5	±50mT	I <sup>2</sup> C	0x0C	Reel
MLX90392ELQ-AAA-013-RE	-40°C to 85°C	UTDFN-8 2x2.5	±50mT	$I^2C$	0x3C	Reel

Table 1: Ordering codes

### Legend:





## 2. Contents

Fe	atu	res a	and B	enefits	1
Ар	plic	atio	n Exa	mples	1
De	scri	iptic	n		1
1.	C	Orde	ring I	nformation	2
2.	C	Cont	ents .		3
3.	e	Sloss	sary o	f Terms	5
4.	Р	ins	Descr	iption and Block Diagram	6
	4.1		Pins [	Description	6
5.	В	Block	c Diag	ram	6
6.	C	Cond	litions	s and Specifications	7
	6.1		Abso	lute Maximum Ratings (AMR)	7
	6.2		Oper	ating Conditions	7
	6	5.2.1	. (	General Operating Conditions	7
	6	5.2.2	.	Electrical Operating Conditions	7
	6	5.2.3	.	Magnetic Operating Conditions	7
	6	5.2.4	.	<sup>2</sup> C Timings Conditions	8
	6.3		Elect	rical Specifications	9
	6.4		Magr	netic Specifications	.11
	6.5		Timin	ng Specifications	.12
	6.6		Accui	racy Specifications	.14
7.	F	unc	tiona	Description & Interfaces	.15
	7.1		Oper	ating Modes	.15
	7	'.1.1	. (	Single Measurement Mode	.16
	7	7.1.2	. (	Continuous Measurement Mode	.17
	7	'.1.3	. !	Self-Test Mode (recommended for version -010)	.21
	7	7.1.4	.	Power-Down Mode	.21
	7.2		Outp	ut Protocol (I <sup>2</sup> C) Description	.22
	7	7.2.1	. (	Command Implementation	.22
	7.3		Mem	ory Items Description	.25
	7	'.3.1	.	Memory Structure	.25
	7	7.3.2	.	I/O Registers Description	.26
	7.4		Flow	chart	.31
	7.5		Perfo	rmance Graphs	.32
	7	'.5.1	.	Noise Performance	.32
	7.6		Temp	perature Compensation	.36
8.	Δ	Appli	icatio	n Information	.36
	8.1		Reco	mmended Application Diagram	.36
9.	Р	ack	age a	nd Manufacturability Information	.37

#### MLX90392

#### 3D Magnetometer



9.1.	ES	D Precaution	37
9.2.	Pa	ickage Information	37
9	.2.1.	Dimensions	37
9	.2.2.	Sensing Element Placement	38
9	.2.3.	Marking	38
9.3.	St	andard Information on Soldering Processes	39
10.	Refe	rences	40
10.1	l.	List of Figures	40
10.2	2.	List of Tables	40
11.	Revis	sion History	41
12.	Discl	aimer	42



# 3. Glossary of Terms

Term	Description
NC	Not connected
ADC	Analog-to-digital converter
LSB	Least significant bit
MSB	Most significant bit
Gauss (G)	Units for magnetic flux density – 1mT = 10G
RMS	Root mean square
POR	Power on reset
NV	Non-volatile
DSP	Digital signal processing



## 4. Pins Description and Block Diagram

## 4.1. Pins Description

Pin #	Name (I <sup>2</sup> C)	Description
1	SDA	[I/O] Bus data
2	VDD	[S] Supply
3	VSS	[S] Ground
4	SCL	[I] Bus clock
5	Not used	Not connected
6	Not used	Not connected
7	Not used	Not connected
8	Not used	Not connected

Table 2: Pin description

The exposed pad of the UTDFN-8 package can be left floating or shorted to ground.

# 5. Block Diagram

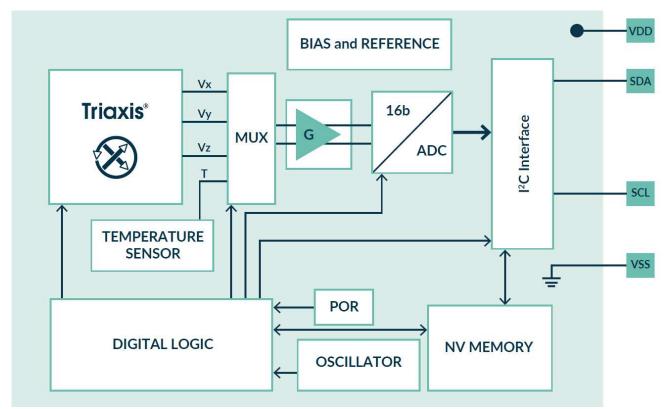


Figure 1: IC block diagram



# 6. Conditions and Specifications

## 6.1. Absolute Maximum Ratings (AMR)

Operating characteristics, T<sub>A</sub> = -40°C to 85°C (unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Supply voltage	$V_{DD}$			2.3	V	<48h
Reverse voltage protection	$V_{\text{DD-rev}}$			-0.3	V	Room temp, <48h
Output voltage	V <sub>SDA</sub> , V <sub>SCL</sub>			2.3	V	<48h
Reverse output voltage	$V_{SDAREV}$			-0.3	V	
Reverse clock output voltage	V <sub>SCLREV</sub>			-0.3	V	
ESD HBM (all pins)				2	kV	
ESD CDM (all pins)				500	V	
Operating temperature	TA	-40		+85	°C	
Junction temperature	$T_{JUNC}$			+85	°C	
Storage temperature	$T_{storage}$	-40		150	°C	
Thermal resistance	R <sub>thja</sub>		230		°C/W	Junction to ambient 1s0p board
			40		°C/W	Junction to ambient multi layered pcb
Thermal resistance	$R_{thjc}$		3.4		°C/W	Junction to case
Magnetic flux density		-1		1	Т	

Table 3: Absolute maximum ratings

Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

## 6.2. Operating Conditions

#### **6.2.1.** General Operating Conditions

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Operating temperature	T <sub>A</sub>	-40		+85	°C	
Storage temperature	$T_{storage}$	-40		150	°C	

Table 4: General operating conditions

### 6.2.2. Electrical Operating Conditions

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Supply voltage	$V_{DD}$	1.65	1.8	1.95	V	

Table 5: Electrical operating conditions

Table 6: Magnetic operating conditions

### **6.2.3.** Magnetic Operating Conditions

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Magnetic flux density		-5		5	mT	Version -010
Magnetic flux density		-50		50	mT	Version -011 Version -013



## **6.2.4.** I<sup>2</sup>C Timings Conditions

Electrical Parameter	Symbol	I <sup>2</sup> C Standard Mode		I <sup>2</sup> C Fast Mode Plus		Unit
Electrical Farallieter	Зуппоот	Min.	Max.	Min.	Max.	Oilit
SCL clock frequency	f (SCL)	0	100	0	1000	kHz
SCL clock low time	tw (SCLL)	4.7		0.5		μs
SCL clock high time	tw (SCLH)	4		0.26		μs
SDA setup time	t <sub>su</sub> (SDA)	250		50		ns
SDA data hold time	th (SDA)	0	3.45	0	0.45	μs
START condition hold time	t <sub>h</sub> (ST)	4		0.26		μs
REPEATED START condition setup time	tsu (SR)	4.7		0.26		μs
STOP condition setup time	t <sub>su</sub> (SP)	4		0.26		μs
Bus free time between STOP and START	tw (SP:ST)	4.7		0.5		μs

Table 7: General I<sup>2</sup>C timing specification

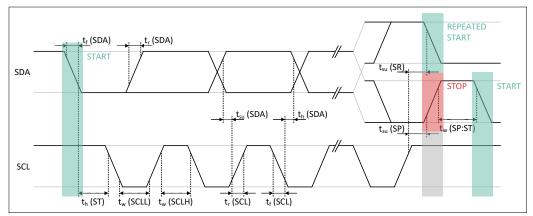


Figure 2: I<sup>2</sup>C timing diagram



## **6.3.** Electrical Specifications

Operating characteristics, T<sub>A</sub> = -40°C to 85°C (unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Power On Reset (rising edge)	V <sub>POR_LH</sub>	1.44	1.5	1.55	V	
ower On Reset (falling edge)	$V_{POR\_HL}$	1.35	1.4	1.45	V	
Conversion current	$I_{DD,CONVXY}$	2.2	2.7	3.5	mA	XY axis, ver010
	$I_{DD,CONVZ}$	2.7	3.6	5.2	mA	Z axis, ver010
Conversion current	I <sub>DD</sub> ,CONVXY	1.4	1.8	2.7	mA	XY axis, ver011 & -013
	$I_{DD,CONVZ}$	1.9	2.8	4.3	mA	Z axis, ver011 & -013
Conversion current	I <sub>DD</sub> ,CONVT	0.6	0.73	0.85	mA	Temperature
Counting state current	I <sub>DD,CNT</sub>	6	11	16	μΑ	
Power-down current	I <sub>DD,PD</sub>	0.4	1.5	3	μΑ	
Average current 100Hz refresh	IDD,AVG100-0	1.8	2.3	3.2	mΑ	Version -010 Continuous mode XYZT, OSR_HALL=1 DIG_FILTXY=4 DIG_FILTZ=5 DIG_FILT_TEMP=1 OSR_TEMP=1 Temp Comp enabled
Average current	I <sub>DD,AVG100-1</sub>	1.2	1.7	2.7	mA	Version -011 & -013
100Hz refresh						Continuous mode XYZT,  OSR_HALL=1  DIG_FILTXY=4  DIG_FILTZ=5  DIG_FILT_TEMP=1  OSR_TEMP=1  Temp Comp enabled
Average current	I <sub>DD</sub> ,AVG100-1	0.7	0.95	1.5	mA	Version -011 & -013
100Hz refresh						Continuous mode XYZT, OSR_HALL=1 DIG_FILTXY=3 DIG_FILTZ=4 DIG_FILT_TEMP=1 OSR_TEMP=1 Temp Comp enabled
Average current	I <sub>DD</sub> ,AVG200-0	1.8	2.45	3.5	mA	Version -010
200Hz refresh						Continuous mode XYZT,  OSR_HALL=1  DIG_FILTXY=3  DIG_FILTZ=4  DIG_FILT_TEMP=1  OSR_TEMP=1  Temp Comp enabled
Average current	I <sub>DD</sub> ,AVG200-1	1.3	1.85	2.8	mA	Version -011 & -013
200Hz refresh						Continuous mode XYZT,  OSR_HALL=1  DIG_FILTXY=3  DIG_FILTZ=4  DIG_FILT_TEMP=1  OSR_TEMP=1  Temp Comp enabled



Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Temperature sensor resolution <sup>(1)</sup>	$T_{RES}$	48	50	52	LSB <sub>16</sub> /°C	
Temperature sensor accuracy	$T_{LIN}$	-3		3	°C	±3sigma
Input level high <sup>(2)</sup>	V <sub>IH</sub>	56	59	63	$%V_{DD}$	SDA, SCL
Input level low <sup>(2)</sup>	$V_{IL}$	43	48	54	$%V_{DD}$	SDA, SCL
Input level hysteresis	$V_{I,HYST}$	5	11	17	$%V_{DD}$	SDA, SCL
Input capacitance <sup>(2)</sup>	Cin		5	10	pF	SDA, SCL
Output level low	Vol		0.5	1	%V <sub>DD</sub>	SDA (Static, 1mA load)
Output on resistance	R <sub>dson</sub>	5	8	14	Ω	±3sigma
Output leakage current			0.1	0.3	μΑ	

Table 8: Electrical operating conditions

 $<sup>^{\</sup>rm 1}$  The data format is 2's complement with 0 lsb corresponding to 0°C

 $<sup>^{\</sup>rm 2}$  This specification relates to the sensor and not the  $I^{\rm 2}C$  bus



## 6.4. Magnetic Specifications

Operating characteristics, T<sub>A</sub> = -40°C to 85°C (unless otherwise specified)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
XY magnetic sensitivity	SENS <sub>XY</sub>	0.135 1.33	0.15 1.5	0.165 1.67	μT/LSB	Version -010 Version -011 & -013 Room temperature
Z magnetic sensitivity	SENSz	0.135 1.33	0.15 1.5	0.165 1.67	μT/LSB	Version -010 Version -011 & -013 Room temperature
Magnetic measurement range	Brange	±4421 ±43560	±4912 ±49128	±5403 ±54696	μT μT	Version -010 Version -011 & -013 Room temperature
RMS noise <sup>(3)</sup>	N <sub>XYZ</sub>		2.2	2.4	μTrms	Version -010 Room temperature with temperature compensation – 5ms conv time (DIG_FILTXY=3, DIG_FILTZ=4, OSR_HALL=1)
RMS noise <sup>(3)</sup>	Nxyz		1.5	1.7	μTrms	Version -010 Room temperature without temperature compensation 5ms conv time (DIG_FILTXY=3, DIG_FILTZ=4, OSR_HALL=1)
RMS noise <sup>(3)</sup>	Nxyz		11	12	μTrms	Version -011 & -013 Room temperature without temperature compensation – 5ms conv time (DIG_FILTXY=3, DIG_FILTZ=4, OSR_HALL=1)
RMS noise <sup>(3)</sup>	N <sub>XYZ</sub>		20	21	μTrms	Version -011 & -013 Room temperature with temperature compensation - 5ms conv time (DIG_FILTXY=3, DIG_FILTZ=4, OSR_HALL=1)
Sensitivity drift	$SENS_THD$	-10		10	%	vs. Ta=35°C
Hysteresis	Bh	200			μΤ	

Table 9: Magnetic specifications

 $<sup>^{\</sup>rm 3}$  Not validated by any production test, only verified by characterization



## 6.5. Timing Specifications

Operating characteristics, T<sub>A</sub> = -40°C to 85°C (unless otherwise specified)

operating characteristics, 14				<b></b> ,		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
	Fr1	10	100	700	Hz	With temperature compensation (5)
Output refresh rate <sup>(4)</sup>	Fr2			1400	Hz	Without temperature compensation <sup>(5)</sup>
Oscillator trimming accuracy	Tosc_trim	-5	0.5	5	%	
Oscillator thermal drift	$T_{OSC\_THD}$	-5	0	5	%	
	T <sub>CONVM</sub>	105	111	117	μs	Time per axis DIG_FILT=0, OSR=0
Magnetic axis conversion	T <sub>CONVM</sub>	202	213	224	μs	Time per axis DIG_FILT=0, OSR=1
time <sup>(6)</sup>	T <sub>CONVM</sub>	912	960	1008	μs	Time per axis DIG_FILT=3, OSR=1
	T <sub>CONVM</sub>	13.1	13.8	14.5	ms	Time per axis DIG_FILT=7, OSR=1
Start-up time	T <sub>Startup</sub>		0.15	1.2	ms	Reset to power- down mode
DSP time	$T_{DSP}$	360	380	400	μs	with temp compensation enabled <sup>(3)</sup>
		220	235	250	μs	with temp compensation disabled <sup>(3)</sup>

Table 10: Timing specifications

\_

<sup>&</sup>lt;sup>4</sup> Fr1 and Fr2 are defined as the period between two set of measurements. It is relevant for the Continuous measurement mode and is defined by the parameter MODE[3:0]. TREFRESH is adjustable with the following settings: 10Hz, 20Hz, 50Hz, 100Hz, 200Hz, 500Hz and 1.4kHz. The default value in the non-volatile memory is 100Hz.

 $<sup>^{\</sup>rm 5}$  The temperature compensation can be enabled or disabled by the user.

<sup>&</sup>lt;sup>6</sup> This conversion time is defined as the time to acquire a single axis of the magnetic flux density. When measuring XYZ, they are obtained through time-multiplexing. The conversion time is programmable through DIG\_FILT for magnetic and temperature conversion. The total conversion time is obtained by summing up the magnetic & temperature conversion time.



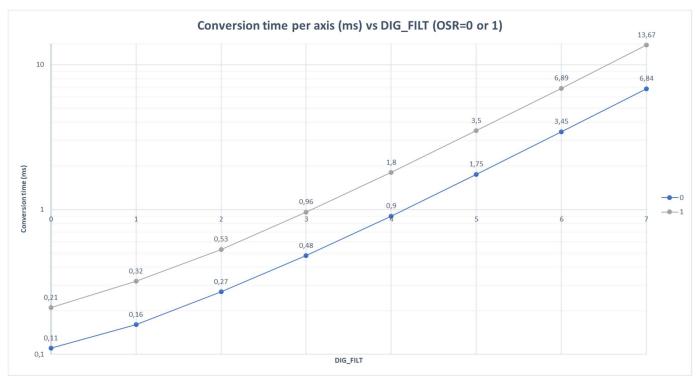


Figure 3: Conversion time

The above graph can be expressed with the following formula:

$$\mathsf{T}_{\mathsf{conv}} \big( \mathsf{DIG\_FILT} \big) = \frac{16}{\mathsf{F}_{\mathsf{clk}}} + \frac{\mathsf{OSR}}{\mathsf{F}_{\mathsf{clk}}} \cdot \left( 2^{\mathsf{DIG\_FILT} + 2} + 4 \right) \qquad \mathsf{F}_{\mathsf{clk}} = 2.4 \mathsf{MHz} \quad \mathsf{typical}$$



## 6.6. Accuracy Specifications

Operating characteristics,  $T_A = -40$ °C to 85°C (unless otherwise specified). All specifications in this chapter are given with  $\pm 3$  sigma.

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Resolution <sup>(7)</sup>			16		bits	XYZ
Offset <sup>(8)</sup>	O <sub>FFSX</sub> O <sub>FFSY</sub> O <sub>FFSZ</sub>	-1100 -1100 -300	-200 -200 300	700 700 900	LSB <sub>16</sub>	Version -010 Output at 0Gauss. Room temperature
Offset thermal drift X-axis Offset thermal drift Y-axis Offset thermal drift Z-axis		-840 -750 -440		1030 870 470	LSB <sub>16</sub>	Version -010 vs. 35°C
Offset <sup>(8)</sup>	Offsx Offsy Offsz	-150 -330 -340	40 -130 80	220 70 500	LSB <sub>16</sub>	Version -011 & -013 Output at 0Gauss. Room temperature
Offset thermal drift X-axis Offset thermal drift Y-axis Offset thermal drift Z-axis		-120 -100 -220		90 120 190	LSB <sub>16</sub>	Version -011 & -013 vs. 35°C
Mismatch on the raw signals X, Y and Z	Smismxy Smismxz Smismyz	-5 -5 -3	-1 -2 -1	2 1 1	%	Version -010
Thermal drift of sensitivity mismatch		-110		225	ppm/°C	Version -010
Mismatch on the raw signals X, Y and Z	S <sub>MISMXY</sub> S <sub>MISMXZ</sub> S <sub>MISMYZ</sub>	-3 7 6	1 10 9	5 13 11	%	Version -011 & -013
Thermal drift of sensitivity mismatch		-140		265	ppm/°C	Version -011 & -013
Cross-axis sensitivity <sup>(9)</sup>	Sxyi Syxi Sxzi Szxi Syzi Szyi	-1.8 -2.7 -8.0 -5.0 -5.7 -4.8	0.5 -0.7 -3.2 -0.2 0.5 0.9	2.6 1.3 1.8 4.5 6.6	%	Version -010 (verified by characterization / not by final testing)
Cross-axis sensitivity <sup>(9)</sup>	S <sub>XYI</sub> Syxi Sxzi Szxi Syzi Szyi	-1.5 -1.7 -1.3 -3.0 -9.6 -3.3	0.2 0.0 4.9 1.0 -6.3 -1.6	1.9 1.8 12.4 5.6 -4.1 -0.5	%	Version -011 & -013 (verified by characterization / not by final testing)

Table 11: Accuracy specifications

<sup>&</sup>lt;sup>7</sup> The data format is 2's complement, further explanation can be found on chapter 7.1.2.6.

<sup>&</sup>lt;sup>8</sup> Value of measurement data register on shipment test without applying magnetic field on purpose. These values are guaranteed in the operating magnetic field range.

<sup>&</sup>lt;sup>9</sup> The cross axis sensitivity is measured by applying a force field on one axis and measured on another axis. For instance, SXYi means that a field was applied along X axis and measured along Y axis.



# 7. Functional Description & Interfaces

## 7.1. Operating Modes

MLX90392 has the following application modes

- 1. Power-down mode
- 2. Single measurement mode
- 3. Continuous measurement mode (10Hz, 20Hz, 50Hz, 100Hz, 200Hz, 500Hz, 700Hz and 1.4kHz)
- 4. Self-test mode

Operating Mode	Start of Mode	End of Mode (Return to power-down mode)	Measurement Data
Single measurement	Command to enter mode 1 or 9	Measurement finished	(T)XYZ
Continuous mode	Command to enter mode 2, 3, 4, 5, 10, 11, 12, 13	Transition to other mode	(T)XYZ
Power-down mode	Power up or command to enter mode 0, 7, 8, 15	Transition to other mode	-
Self-test mode	Command to enter mode 6 and 14 from power-down mode	Measurement finished	Z

For single measurement, mode 1 and 9 will be similar. Same for continuous mode and self-test mode.



#### 7.1.1. Single Measurement Mode

When the *Single measurement mode* is set, a magnetic measurement is started. After a measurement and when the signal processing is finished, the measurement data is stored to the data registers (**X**, **Y** and **Z**). After this, the sensor will go to the *power-down mode* automatically.

While going to the *power-down mode*, **MODE[3:0]** bits turns to 0. At the same time, **DRDY** bit (Data Ready) in **STAT1** register turns to High.

When any of measurement data register (**X**, **Y** and **Z**) is read, **DRDY** bit turns to Low. It remains High when switching from *power-down mode* to another mode.

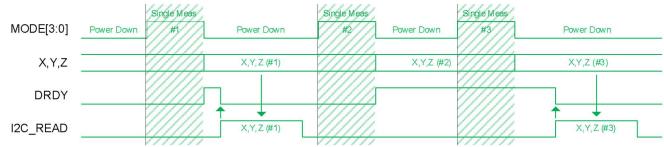


Figure 4: Single measurement mode when data is read out of measurement period

When the sensor is measuring, the data registers (**X**, **Y** and **Z**) keep the previous data. Therefore, it is possible to read out data even during measurement periods.

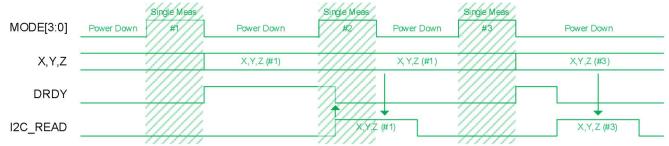


Figure 5: Single measurement mode when data read started during measurement period



#### 7.1.2. Continuous Measurement Mode

When the "Continuous measurement" mode is set, the measurement starts periodically. After measurement and signal processing is finished, the measurement data is stored to the data registers (X, Y, and Z). Almost all internal blocks are disabled ("Counting" power state).

After a measurement period, **the device** wakes up automatically from "*Counting*" power state and starts a new measurement.

The Continuous measurement mode ends when "power-down" mode (MODE[3:0] bits = 0) is set. If the measurement period is changed while <u>the device</u> is already configured in "Continuous measurement" mode, a new measurement starts.

**STAT1** and measurement data registers (**X**, **Y** and **Z**) will not be initialized by this.



Figure 6: Continuous measurement mode

#### 7.1.2.1. Data Ready

When the measurement data is stored and ready to be read, the **DRDY** bit (Data ready) in STAT register is set to High. When a measurement is performed correctly, the device sets the Data Ready bit before going back to "Counting" power state.

#### 7.1.2.2. Normal Read Sequence

The stored measurement data is protected during the data reading. There is no update of the data during this time. Consequently, the following sequence should be followed:

- 1. Check if the Data is Ready or not by polling DRDY bit of STAT1 register
  - a. **DRDY**: Data Ready. The Data is ready when set High.
- 2. Reading of the STAT1 register will not trigger the protection.
- 3. **Read measurement data** When **any of** the measurement data register (X, Y, or Z) is read, the device enables the protection as soon as the register is copied into the I<sup>2</sup>C sending register. When data reading starts, **DRDY (Data ready)** bit turns Low.
- 4. Read STAT2 register (required for data consistency provides information on overflow and data skip)

When this read sequence is followed and there is no attempted I<sup>2</sup>C read during measurement, reading of STAT2 sets the DOR bit to low (see I/O Registers for reference).



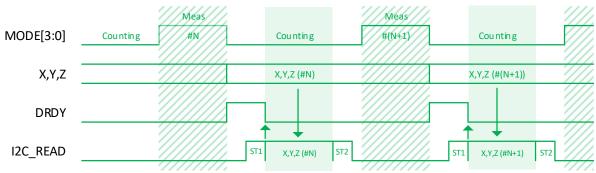


Figure 7: Normal read sequence

#### 7.1.2.3. Data Read Start during Measurement

When the sensor is measuring, the measurement data registers (**X**, **Y** and **Z**) keep the previous data. Therefore, it is possible to read out data even in measurement period.

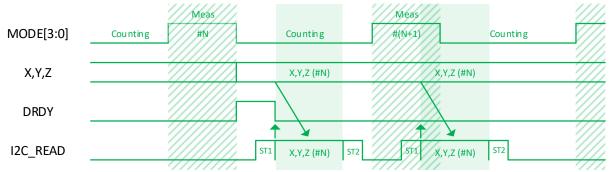


Figure 8: Data read start during measurement



#### 7.1.2.4. Data Skip

If the available data is not read before a new measurement ends, the DRDY bit (Data Ready) remains High. However, a new set of measurement data will replace the previous one.

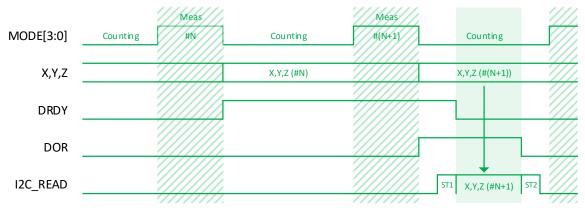


Figure 9: Data skip: When data is not read

If the available data is read while a new measurement is being performed, this set of data will be protected. This is also the case even if the reading procedure finishes after the measurement. Consequently, this new set of data is skipped.

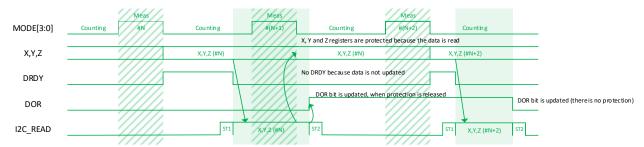


Figure 10: Data skip: When data read has not been finished before the next measurement end



#### 7.1.2.5. End Operation

Set the power-down mode (MODE[3:0] bits = 0) to end the Continuous measurement mode.

#### 7.1.2.6. Magnetic Sensor Overflow

#### Version -010

The sum of absolute values of each axis must be smaller than  $4912\mu T$  to avoid an overflow. (BRG:  $0.15\mu T/LSB$ )

$$|X|+|Y|+|Z| < 4912\mu T$$

2's complement	Hex	Dec	Magnetic flux density [μΤ]
0111_1111_1111_0000	7FF0	32752	4912
0000_0000_0000_0001	0001	1	0.15
0000_0000_0000_0000	0000	0	0
1111_1111_1111_1111	FFFF	-1	-0.15
1000_0000_0001_0000	8010	-32752	-4912

Table 12: Measurement magnetic data format

#### Version -011 & -013

The sum of absolute values of each axis must be smaller than **49.13mT** to avoid an overflow. (BRG: **1.5**µ**T/LSB**)

$$|X|+|Y|+|Z| < 49.13mT$$

2's complement	Hex	Dec	Magnetic flux density [mT]
0111_1111_1111_0000	7FF0	32752	49.13
0000_0000_0000_0001	0001	1	0.0015
0000_0000_0000_0000	0000	0	0
1111_1111_1111_1111	FFFF	-1	-0.0015
1000_0000_0001_0000	8010	-32752	-49.13

Table 13: Measurement magnetic data format

The calculation is done as follows:

When the magnetic field exceeds this limitation, this is a Magnetic Sensor Overflow. When magnetic sensor overflow occurs, **HOVF** bit turns to "High". The **HOVF** bit is updated as soon as the measurement data register (**X**, **Y** and **Z**) is updated.



#### 7.1.3. Self-Test Mode (recommended for version -010)

The self-test mode is used to check if the magnetic sensor is working normally.

When the self-test mode is set, a magnetic field is generated by the internal magnetic source and a measurement is performed. The data is stored to the data registers (X, Y and Z). The sensor will then go to power-down mode automatically. The correct sequence to set the self-test mode is described below:

#### 7.1.3.1. Self-Test Sequence

- 1. Set power-down mode.
- 2. Set Self-test mode.
- 3. Check Data Ready or not by polling DRDY bit (Data Ready) of STAT1 register.
  - a. When the data is ready, proceed to the next step.
- 4. Read measurement data. (X, Y and Z)

#### 7.1.3.2. Self-Test Judgment (used by the customer)

The following criteria will help the user to decide if the sensor is correctly calibrated.

DeltaX[15		DeltaX[15:0]	DeltaY[15:0]	DeltaZ[15:0]	Units
	Criteria	-150 ≤ X ≤ 150	-150 ≤ Y ≤ 150	-1200 ≤ Z ≤ -400	LSB16

The typical magnetic field generated by the internal coil is around 135µT at room temperature. The self-test judgement are the expected values over temperature and voltage variations.

#### 7.1.4. Power-Down Mode

In power-down mode, the device is in minimal power consumption state. All internal blocks including the oscillator are disabled except the POR circuit. Only the communication over the I<sup>2</sup>C interface is maintained. The digital handling of the communication is clocked by the I<sup>2</sup>C master clock. All registers remain accessible and the data stored in read/write registers remains.



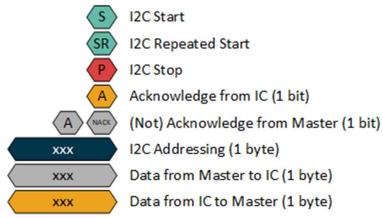
## 7.2. Output Protocol (I<sup>2</sup>C) Description

#### 7.2.1. Command Implementation

The following I<sup>2</sup>C commands are implemented:

- MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00
- **MEM\_READ**: the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop is detected.
- **MEM\_WRITE**: the start address will be specified followed by the data to be stored at addresses starting from the given start address and incremented until an I<sup>2</sup>C stop is detected.
- ADDRESSED\_RESET: reset of the device, based on the I<sup>2</sup>C Slave Address (reset of addressed devices on the I<sup>2</sup>C bus only)

In the next sections, the format of the different I<sup>2</sup>C commands is explained. The following legend is used:



3D Magnetometer



#### 7.2.1.1. Read Commands

There are two read commands that are implemented

- MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00
- **MEM\_READ**: the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop is detected.

#### 7.2.1.1.1 MEM\_DIRECT\_READ (direct read) Command

MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00



Figure 11: I<sup>2</sup>C - MEM\_DIRECT\_READ (direct read) Command

#### **NOTES:**

- Incremental readout return 0x00 when address out of valid space
- NAK is needed from master to allow going to STOP

#### 7.2.1.1.2. MEM\_READ (addressed read)

**MEM\_READ:** the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop (P) is detected.

Incremental read-out starting at a given address (Register Start Address).

Normally it will read 1x register only, but the slave will continue to transmit data of sequential register addresses until the master terminates the communication.



Figure 12: I<sup>2</sup>C - MEM\_READ (addressed read)

Important! A repeated START is required to perform an "addressed read". Without repeated START, the command will be seen as a "direct read".

As soon as incremental addressing leaves the address space, the slave will respond with all 0x00. NOTES:

- Incremental readout return 0x00 when address out of valid space
- NAK is needed from master to allow going to STOP



#### 7.2.1.2. MEM\_WRITE (addressed write) Command

**MEM\_WRITE:** the start address will be specified followed by the data to be stored at addresses starting from the given start address and incremented until an I<sup>2</sup>C stop (P) is detected.

Incremental write starting at a given address (Register Start Address).

Normally you write 1x register only, but optionally the master can continue to transmit data of sequential register addresses to reduce the communication time when a lot of registers should be written.



The slave is sending AK/NAK based on the fact whether it was able to write data

The slave will automatically increment the address of the read out byte, independent if it gave an AK or a NAK to the master. It is up to the master to re-write the byte afterwards.

When the device is busy with the write operation, new write commands will be ignored. A read operation will return invalid data.

#### 7.2.1.3. ADDRESSED\_RESET: Addressed reset



The addressed reset command brings the device back into a state like it was after power-on.

The I<sup>2</sup>C slave address is used, which means that only the addressed devices on the I<sup>2</sup>C bus will be reset.



## 7.3. Memory Items Description

### 7.3.1. Memory Structure

The MLX90392 has registers (ports) of 16 addresses. Each address consists of 8 bits data. Data is transferred to or received from the external CPU via the I<sup>2</sup>C interface.

Address	Name	Description	R/W	7	6	5	4	3	2	1	0
0x00	STAT1	Status Register 1			-	-	-	RT	-	-:	DRDY
0x01	X[7:0]	X-axis Measurement Magnetic Data [7:0]		-	-	-	-	-	-	-	-
0x02	X[15:8]	X-axis Measurement Magnetic Data [15:8]	R	-	-	-	-	-	-	-	1-
0x03	Y[7:0]	Y-axis Measurement Magnetic Data [7:0]	R	-	-	-	-	-	-	-	12
0x04	Y[15:8]	Y-axis Measurement Magnetic Data [15:8]	R	-	-	-	-	-	-	-	1-
0x05	Z[7:0]	Z-axis Measurement Magnetic Data [7:0]	R	-	-	-	-		1		
0x06	Z[15:8]	Z-axis Measurement Magnetic Data [15:8]	R	-	8	124	-		-	¥	-
0x07	STAT2	Status Register 2	R	8	-	=	-	-	-	DOR	HOVF
0x08	T[7:0]	Temperature Measurement Data Lower 8-bit	R	-	8	=	-	, <del>t</del>	Ξ.	9.0	π
0x09	T[15:8]	Temperature Measurement Data Higher 8-bit		-	-	-		~	-	-	-
0x0A	CID	Company ID [7:0]	R	-	1-	-	-	ē	-	5.	. =
0x0B	DID	Device ID [7:0]	R	-	-	-	-	-	-	-	-
0x0C		Not used		-		=		-	=	F1	-
0x0D		Not used		=	-	=	e	-	-	-	-
0x0E		Not used		=	-	=	(5)	=	=	=	=
0x0F		Not used		1-1	-	-	-	-	-	-	-
0x10	CTRL	Control Register (Application Mode)	R/W	.94		#			MOD	DE[3:0]	
0x11	RST	Reset = 0x06	R/W		~	1-1	-	~	-	~.	-
0x12		Not used		-	-	-	-:	-			
0x13		Not used		-	-	-	-	-	-		-
0x14	OSR_DIG_FILT	OSR_DIG_FILT[7:0]	R/W	OSR_HALL	OSR_TEMP	DIG_F	ILT_HALL_XY[	2:0]	DIG	_FILT_TEM	P[2:0]
0x15	T_EN_DIG_FILT_Z	CUST_CTR	R/W	DNC=1	DNC=0	T_COMP_EN	DNC=1	-	DIG	FILT_HALL	Z[2:0]

Table 14: Memory map

#### **DNC**=Do Not Change

The **STAT1** register is mapped on address **0x00**, since it is the default address of **MEM\_DIRECT\_READ** (direct read) command.

The idea is that first the user has to read the status bits **DRDY** to check if there is new data and if there is new data, to continue the command to read the registers **X**, **Y** and **Z**.



## 7.3.2. I/O Registers Description

### 7.3.2.1. Address 0x00: STAT1[7:0]

7	6	5	4	3	2	1	0
STAT1_7	STAT1_6	STAT1_5	STAT1_4	RT	STAT1_2	STAT1_1	DRDY
RW-0	RW-0	RW-0	RW-0	RW-1	RW-0	RW-0	RW-0

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

Bit 7-4	STAT1[7:4] Reserved (Not used)					
Bit 3	RT The device is reset					
	0 – The device was not reset					
	1 – The device was reset and this is the first reading. Automatically set to 0 when the first reading					
	of STAT register is done.					
Bit 2-1	STAT1[2:1] Reserved (Not used)					
Bit 0	DRDY Data ready					
	DRDY bit turns to "1" when data is ready in "Single measurement" mode, "Continuous					
	measurement" mode or "Self-test" mode. It returns to "0" when any one the measurement data					
	register (X, Y, or Z ) is read.					
	0 – Normal					
	1 – Data is ReaDY					

#### 7.3.2.2. Addresses 0x01-0x06: XYZ[15:0]

0x01	X[7:0] LSByte of X-axis
0x02	X[15:8] MSByte of X-axis
0x03	Y[7:0] LSByte of Y-axis
0x04	Y[15:8] MSByte of Y-axis
0x05	<b>Z[7:0]</b> LSByte of Z-axis
0x06	Z[15:8] MSByte of Z-axis



#### 7.3.2.3. Address 0x07: STAT2[7:0]

7	6	5	4	3	2	1	0
STAT2_7	STAT2_6	STAT2_5	STAT2_4	STAT2_3	STAT2_2	DOR	HOVF
RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

Bit 7-2	STAT2[7:2] Reserved (Not used)			
Bit 1	DOR Data overrun			
	DOR bit turns to "1" when data has been skipped in "Continuous measurement" mode. It returns to			
	"0" when the data registers (X, Y, Z) are read.			
	0 – Normal			
	1 – Data OverRun			
Bit 0	HOVF Magnetic sensor overflow			
	0 – Normal			
	1 – Magnetic Sensor OVerFlow occured			

In "Single measurement" mode, "Continuous measurement" mode and "Self-test" mode, the magnetic sensor may overflow even though the measurement data register is not saturated. In this case, measurement data is not correct and HOVF bit turns to "1". When the measurement data register is updated, HOVF bit is updated.

#### 7.3.2.4. Addresses 0x08-0x09: T[15:0]

0x08	T[7:0] LSByte of the temperature
0x09	T[15:8] MSByte of the temperature

#### 7.3.2.5. Address 0x0A: CID[7:0]

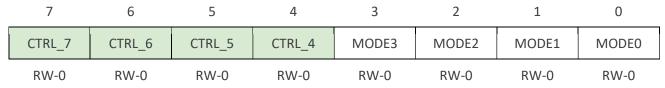
0x0A	CID[7:0]	Company ID	

#### 7.3.2.6. Address 0x0B: DID[7:0]

0x0B	DID[7:0] Device ID	
------	--------------------	--



#### 7.3.2.7. Address 0x10: CTRL[7:0]



NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

Bit 7-4	CTRL[7:4] Reserved (Not used)			
Bit 3-0	MODE[3:0] Application mode			
	0 – Power-down mode			
	1 – Single measurement mode			
	2 – Continuous measurement mode 10Hz			
	3 – Continuous measurement mode 20Hz			
	4 – Continuous measurement mode 50Hz			
	5 – Continuous measurement mode 100Hz			
	6 – Self-test mode			
	7 – Power-down mode			
	8 – Power-down mode			
	9 – Single measurement mode			
	10 – Continuous measurement mode 200Hz			
	11 – Continuous measurement mode 500Hz			
	12 – Continuous measurement mode 700Hz			
	13 – Continuous measurement mode 1.4kHz			
	14 – Self-test mode			
	15 – Power-down mode			

### 7.3.2.8. Address 0x11: RST[7:0]

0x11	RST[7:0]	Addressed RESET when users sends an I2C_ADDRESSED_RESET command
------	----------	---

#### 7.3.2.9. Addresses 0x12-0x13: Not used

3D Magnetometer



### 7.3.2.10. Address 0x14: OSR\_DIG\_FILT[7:0]

7 6 5 4 3 2 1 0

OSR_HALL	OSR_TEMP	DIG_FILT_HA LL_XY2	DIG_FILT_HA LL_XY1	DIG_FILT_HA LL_XY0	DIG_FILT_TE MP2	DIG_FILT_TE MP1	DIG_FILT_TE MP0
RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

Bit 7	OSR_HALL Over Sampling Ratio setting for the magnetic measurements
	0 – 32
	1 – 64
Bit 6	OSR_TEMP Over Sampling Ratio setting for the temperature measurement
	0 – 32
	1 – 64
Bit 5-3	DIG_FILT_HALL_XY[2:0] DIG_FILT setting for X and Y magnetic measurements
	0 – 0.113ms @ OSR = 0; 0.220ms @ OSR = 1
	1 – 0.167ms @ OSR = 0; 0.327ms @ OSR = 1
	2 – 0.273ms @ OSR = 0; 0.540ms @ OSR = 1
	3 – 0.487ms @ OSR = 0; 0.967ms @ OSR = 1
	4 – 0.913ms @ OSR = 0; 1.820ms @ OSR = 1
	5 – 1.767ms @ OSR = 0; 3.527ms @ OSR = 1
	6 – 3.473ms @ OSR = 0; 6.940ms @ OSR = 1
	7 – 6.887ms @ OSR = 0; 13.767ms @ OSR = 1
Bit 2-0	<b>DIG_FILT_TEMP[2:0]</b> DIG_FILT setting for the temperature measurements
	0 – 0.113ms @ OSR = 0; 0.220ms @ OSR = 1
	1 – 0.167ms @ OSR = 0; 0.327ms @ OSR = 1
	2 – 0.273ms @ OSR = 0; 0.540ms @ OSR = 1
	3 – 0.487ms @ OSR = 0; 0.967ms @ OSR = 1
	4 – 0.913ms @ OSR = 0; 1.820ms @ OSR = 1
	5 – 1.767ms @ OSR = 0; 3.527ms @ OSR = 1
	6 – 3.473ms @ OSR = 0; 6.940ms @ OSR = 1
	7 – 6.887ms @ OSR = 0; 13.767ms @ OSR = 1



### 7.3.2.11. Addresses 0x15: CUST\_CTRL[7:0]

7	6	5	4	3	2	1	0
DNC = 1	DNC = 0	T_COMP_EN	DNC = 1	CUST_CTRL3	DIG_FILT_HA LL_Z2	DIG_FILT_HA LL_Z1	DIG_FILT_HA LL_Z0
RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0	RW-0

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

Bit 7	DNC=1 Value is preloaded from OTP with 0b1. Do not change it!
Bit 6	DNC=0 Value is preloaded from OTP with 0b0. Do not change it!
Bit 5	T_COMP_EN Enable or disable the temperature measurement and compensation
	0 – Disabled
	1 – Enabled
Bit 4	DNC=1 Value is preloaded from OTP with 0b1. Do not change it!
Bit 3	CUST_CTRL3 Reserved (Not used)
Bit 2-0	DIG_FILT_HALL_Z[2:0] DIG_FILT setting for Z magnetic measurements
	0 – 0.113ms @ OSR = 0; 0.220ms @ OSR = 1
	1 – 0.167ms @ OSR = 0; 0.327ms @ OSR = 1
	2 – 0.273ms @ OSR = 0; 0.540ms @ OSR = 1
	3 – 0.487ms @ OSR = 0; 0.967ms @ OSR = 1
	4 – 0.913ms @ OSR = 0; 1.820ms @ OSR = 1
	5 – 1.767ms @ OSR = 0; 3.527ms @ OSR = 1
	6 – 3.473ms @ OSR = 0; 6.940ms @ OSR = 1
	7 – 6.887ms @ OSR = 0; 13.767ms @ OSR = 1



### 7.4. Flowchart

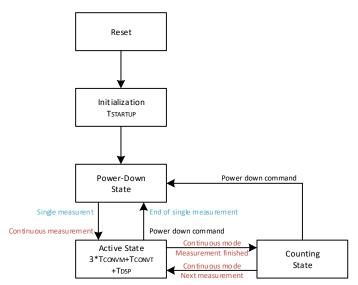


Figure 15: Sequence flowchart



## 7.5. Performance Graphs

#### 7.5.1. Noise Performance

#### 7.5.1.1. Version -010 - Without temperature compensation

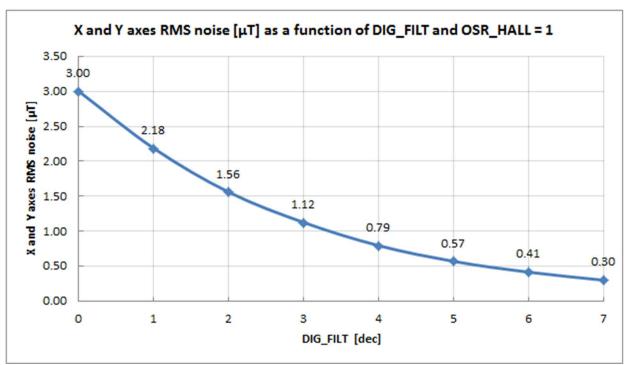


Figure 16: version -010 - XY axis RMS noise (typical)

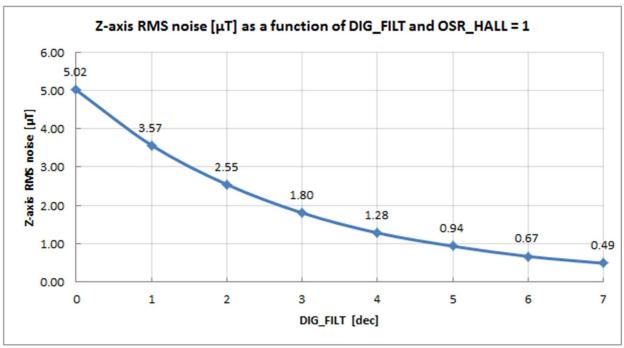


Figure 17: version -010 - Z axis RMS noise (typical)

Note: When OSR\_HALL is set to 0, the above values have to be scaled by sqrt(2).



#### 7.5.1.2. With temperature compensation and maximum field

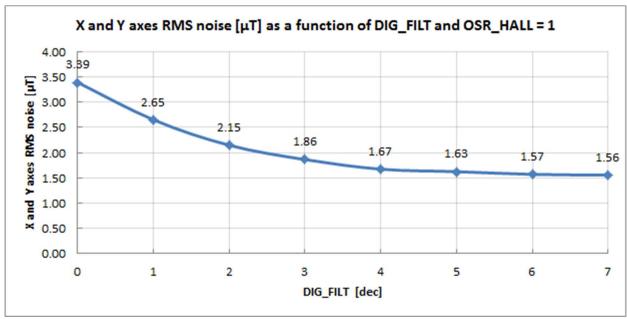


Figure 18: version -010 - XY axes RMS noise (typical)

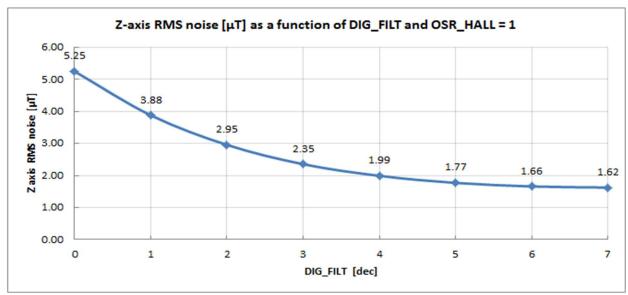


Figure 19: version -010 - Z axis RMS noise (typical)



#### 7.5.1.3. Version -011 & -013 - Without temperature compensation

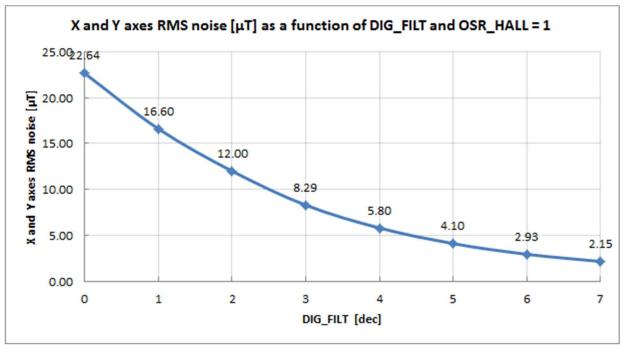


Figure 20: version -011 & -013 – XY axis RMS noise (typical)

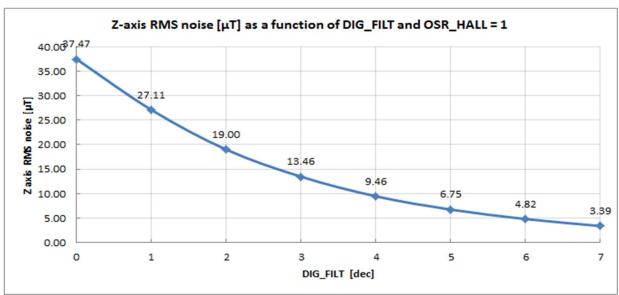


Figure 21: version -011 & -013 - Z axis RMS noise (typical)



#### 7.5.1.4. With temperature compensation and maximum field

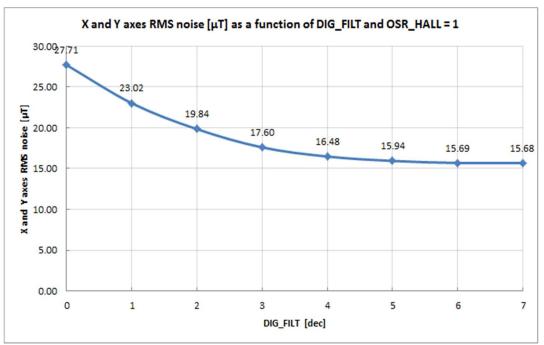


Figure 22: version -011 & -013 - XY axis RMS noise (typical)

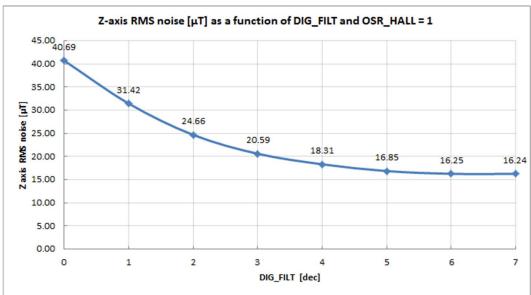


Figure 23: version -011 & -013 - Z axis RMS noise (typical)



### 7.6. Temperature Compensation

The MLX90392 has a built-in temperature compensation, which is done by a piecewise linear approximation of the temperature coefficient of the Hall plates. A reference temperature is chosen (TREF=35°C), where the result at any temperature, higher than TREF is adjusted by a gain SENT\_TC\_HT and if the temperature is lower than TREF - by SENS\_TC\_LT. These two coefficients are calibrated at Melexis and are lumped into the parameter name SENS\_TC in the equation below.

$$\mathsf{XYZ}_{18\_0} = \mathsf{XYZ\_RAW}_{18\_0} \cdot \left[ 1 + \frac{\mathsf{SENS\_TC}_{11\_0} \cdot \left( \mathsf{TEMP}_{15\_0} - \mathsf{TREF}_{15\_0} \right)}{2^{\mathsf{SENS\_TC}_{13\_0} + 18}} \right]$$

SENS\_TC\_N is a scaling factor needed for the fixed-point calculations. It is determined and written at Melexis during production test.

In case the temperature compensation is not needed, bit 5 in T\_EN\_DIG\_FILT\_Z register is set to 0. This also disables the temperature measurement and the term in the square brackets of the formula above is equal to 1.

The operation is executed on the 19 bits raw magnetic data which is consequently truncated to 16 bit and loaded into the results registers.

## 8. Application Information

### 8.1. Recommended Application Diagram

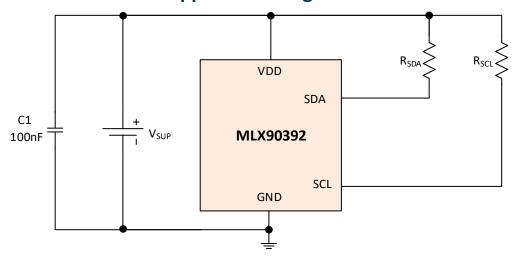


Figure 24: Recommended application diagram

Note: R<sub>SDA</sub> and R<sub>SCL</sub> are part of the bus specifications. Please refer to it.



#### **Package and Manufacturability Information** 9.

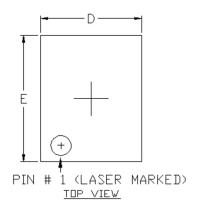
#### **ESD Precaution** 9.1.

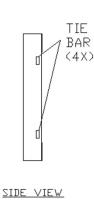
Electronic semiconductor products are sensitive to Electro Static Discharge (ESD). Always observe Electro Static Discharge control procedures whenever handling semiconductor products.

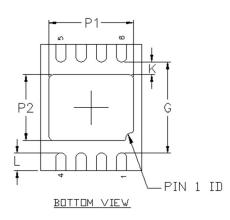
#### **Package Information** 9.2.

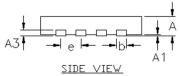
#### 9.2.1. Dimensions

UTDFN 2x2.5mm









	_  A
<b>-</b>  b -	† †
ΞW	Α1

#### NOTE :

- 1. ALL DIMENSIONS IN MILLIMETERS (mm).
  2. EXPOSED TIE BAR SHOULD BE KEPT FREE FROM SOLDER.

ഗ≻≥യഠച	MINIMUM	MAXIMUM
Α	0.31	0.40
A1	0.00	0.05
А3	0.12	REF
D	1.90	2.10
Ε	2.40	2.60
P1	1.45	1.70
P2	1.25	1.35
G	1.75	1 <i>.</i> 85
L	0.25	0.45
K	0.20	
ь	0.16	0.24
e	0.40	BSC



## 9.2.2. Sensing Element Placement

#### Magnetic sweet spot

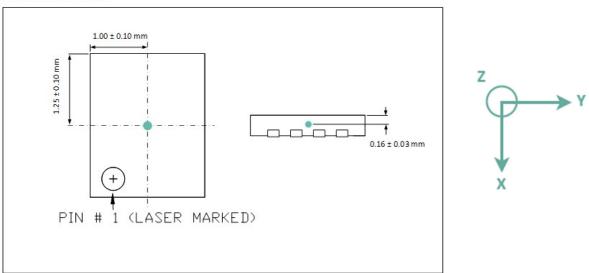


Figure 25: Field convention (Top view of the package with pin 1 at the bottom left)

### **9.2.3.** Marking

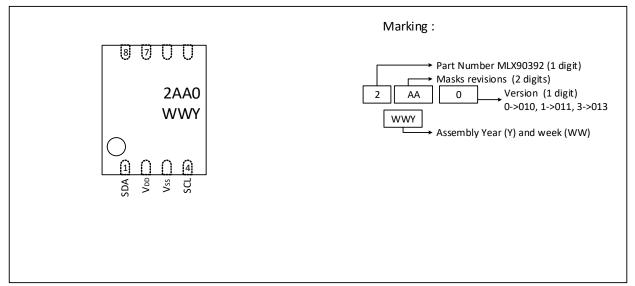


Figure 26: Marking



### 9.3. Standard Information on Soldering Processes

Our products are classified and qualified regarding soldering technology, solderability and moisture sensitivity level according to standards in place in Semiconductor industry.

For further details about test method references and for compliance verification of selected soldering method for product integration, Melexis recommends reviewing on our web site the General Guidelines soldering recommendation (http://www.melexis.com/en/quality-environment/soldering)

For all soldering technologies deviating from the one mentioned in above document (regarding peak temperature, temperature gradient, temperature profile etc.), additional classification and qualification tests have to be agreed upon with Melexis.

For package technology embedding trim and form post-delivery capability, Melexis recommends consulting the dedicated trim&form recommendation application note: lead trimming and forming recommendations (http://www.melexis.com/en/documents/documentation/application-notes/lead-trimming-and-forming-recommendations).

Melexis is contributing to global environmental conservation by promoting lead free solutions. For more information on qualifications of RoHS compliant products (RoHS = European directive on the Restriction Of the use of certain Hazardous Substances) please visit the quality page on our website: <a href="http://www.melexis.com/en/quality-environment">http://www.melexis.com/en/quality-environment</a>.



## 10. References

## 10.1. List of Figures

Figure 1: IC block diagram	6
Figure 2: I <sup>2</sup> C timing diagram	8
Figure 3: Conversion time	13
Figure 4: Single measurement mode when data is read out of measurement period	16
Figure 5: Single measurement mode when data read started during measurement period	
Figure 6: Continuous measurement mode	
Figure 7: Normal read sequence	18
Figure 8: Data read start during measurement	
Figure 9: Data skip: When data is not read	19
Figure 10: Data skip: When data read has not been finished before the next measurement end	
Figure 11: I <sup>2</sup> C - MEM_DIRECT_READ (direct read) Command	
Figure 12: I <sup>2</sup> C - MEM_READ (addressed read)	
Figure 13: I <sup>2</sup> C - MEM WRITE (addressed write) Command	
Figure 14: Addressed reset	
Figure 15: Sequence flowchart	31
Figure 16: version -010 - XY axis RMS noise (typical)	
Figure 17: version -010 - Z axis RMS noise (typical)	
Figure 18: version -010 - XY axes RMS noise (typical)	
Figure 19: version -010 - Z axis RMS noise (typical)	
Figure 20: version -011 & -013 – XY axis RMS noise (typical)	
Figure 21: version -011 & -013 - Z axis RMS noise (typical)	
Figure 22: version -011 & -013 - XY axis RMS noise (typical)	
Figure 23: version -011 & -013 - Z axis RMS noise (typical)	
Figure 24: Recommended application diagram	
Figure 25: Field convention (Top view of the package with pin 1 at the bottom left)	
Figure 26: Marking	
10.2. List of Tables	
Table 1: Ordering codes	2
Table 2: Pin description	
Table 3: Absolute maximum ratings	
Table 4: General operating conditions	
Table 5: Electrical operating conditions	
Table 6: Magnetic operating conditions	
Table 7: General I <sup>2</sup> C timing specification	
Table 8: Electrical operating conditions	
Table 9: Magnetic specifications	
Table 10: Timing specifications	
Table 11: Accuracy specifications	
Table 12: Measurement magnetic data format	
Table 13: Measurement magnetic data format	
Table 14: Memory map	
Table 17. Memory map	



# 11. Revision History

Revision	Date	Change history
001	13-Jan-2021	First datasheet issue (JED)
002	15-Apr-2021	Revised specifications. Package dimensions updated + Cosmetic changes (JED)
003	07-Jun-2022	Cosmetic changes, corrections, added version -013



## 12. Disclaimer

The content of this document is believed to be correct and accurate. However, the content of this document is furnished "as is" for informational use only and no representation, nor warranty is provided by Melexis about its accuracy, nor about the results of its implementation. Melexis assumes no responsibility or liability for any errors or inaccuracies that may appear in this document. Customer will follow the practices contained in this document under its sole responsibility. This documentation is in fact provided without warranty, term, or condition of any kind, either implied or expressed, including but not limited to warranties of merchantability, satisfactory quality, non-infringement, and fitness for purpose. Melexis, its employees and agents and its affiliates' and their employees and agents will not be responsible for any loss, however arising, from the use of, or reliance on this document. Notwithstanding the foregoing, contractual obligations expressly undertaken in writing by Melexis prevail over this disclaimer.

This document is subject to change without notice, and should not be construed as a commitment by Melexis. Therefore, before placing orders or prior to designing the product into a system, users or any third party should obtain the latest version of the relevant information.

Users or any third party must determine the suitability of the product described in this document for its application, including the level of reliability required and determine whether it is fit for a particular purpose.

This document as well as the product here described may be subject to export control regulations. Be aware that export might require a prior authorization from competent authorities. The product is not designed, authorized or warranted to be suitable in applications requiring extended temperature range and/or unusual environmental requirements. High reliability applications, such as medical lifesupport or life-sustaining equipment or avionics application are specifically excluded by Melexis. The product may not be used for the following applications subject to export control regulations: the development, production, processing, operation, maintenance, storage, recognition or proliferation of:

- 1. chemical, biological or nuclear weapons, or for the development, production, maintenance or storage of missiles for such weapons;
- 2. civil firearms, including spare parts or ammunition for such arms;
- 3. defense related products, or other material for military use or for law enforcement;
- 4. any applications that, alone or in combination with other goods, substances or organisms could cause serious harm to persons or goods and that can be used as a means of violence in an armed conflict or any similar violent situation.

No license nor any other right or interest is granted to any of Melexis' or third party's intellectual property rights.

If this document is marked "restricted" or with similar words, or if in any case the content of this document is to be reasonably understood as being confidential, the recipient of this document shall not communicate, nor disclose to any third party, any part of the document without Melexis' express written consent. The recipient shall take all necessary measures to apply and preserve the confidential character of the document. In particular, the recipient shall (i) hold document in confidence with at least the same degree of care by which it maintains the confidentiality of its own proprietary and confidential information, but no less than reasonable care; (ii) restrict the disclosure of the document solely to its employees for the purpose for which this document was received, on a strictly need to know basis and providing that such persons to whom the document is disclosed are bound by confidentiality terms substantially similar to those in this disclaimer; (iii) use the document only in connection with the purpose for which this document was received, and reproduce document only to the extent necessary for such purposes; (iv) not use the document for commercial purposes or to the detriment of Melexis or its customers. The confidentiality obligations set forth in this disclaimer will have indefinite duration and in any case they will be effective for no less than 10 years from the receipt of this document.

This disclaimer will be governed by and construed in accordance with Belgian law and any disputes relating to this disclaimer will be subject to the exclusive jurisdiction of the courts of Brussels, Belgium.

The invalidity or ineffectiveness of any of the provisions of this disclaimer does not affect the validity or effectiveness of the other provisions.

The previous versions of this document are repealed.

Melexis © - No part of this document may be reproduced without the prior written consent of Melexis. (2022)

IATF 16949 and ISO 14001 Certified

For the latest version of this document, visit www.melexis.com

## **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Board Mount Hall Effect/Magnetic Sensors category:

Click to view products by Melexis manufacturer:

Other Similar products are found below:

HGPRDT005A AH1894-FA-7 AH277AZ4-AG1 AV-10448 SS41C AH1894-Z-7 TLE4946-1L TLE4976L SS85CA BU52003GUL-E2
AH277AZ4-BG1 AH3376-P-B TLE4941 TLE4945-2L AH3360-FT4-7 TLE4941-1 AH374-P-A SS41-JL AH1913-W-7 AH3373-P-B
MA732GQ-Z MA330GQ-Z S-57K1NBL2A-M3T2U S-57P1NBL9S-M3T4U S-576ZNL2B-L3T2U S-576ZNL2B-A6T8U S-57P1NBL0S-M3T4U S-57A1NSL1A-M3T2U S-57K1RBL1A-M3T2U S-57P1NBH9S-M3T4U S-57P1NBH0S-M3T4U S-57A1NSH1A-M3T2U S-57A1NSH1A-M3T2U S-57A1NSH2A-M3T2U S-57K1NBH1A-M3T2U S-57A1NNL1A-M3T2U S-5701BC11B-L3T2U5 S-57GNNL3S-A6T8U S-57TZ1L1S-A6T8U S-57GSNL3S-A6T8U S-57RBNL9S-L3T2U S-57GDNL3S-L3T2U S-57RBNL8S-L3T2U S-57RBNL9S-A6T8U S-57RBNL8S-L3T2U S-57RBNL9S-L3T2U S-57TZ1L1S-L3T2U S-57TZNL1S-A6T8U